Notice of References Cited Application/Control No. 10/003,109 Examiner Kim-Kwok CHU Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,226,257	05-2001	Morimoto, Yasuaki	369/275.4
	В	US-6,215,759	04-2001	Tanoue et al.	369/275.3
	С	US-6,163,521	12-2000	Konishi et al.	369/275.3
	D	US-6,078,559	06-2000	Takemura et al.	369/275.3
	Е	US-5,933,410	08-1999	Nakane et al.	369/275.3
	F	US-5,754,506	05-1998	Nagasawa et al.	369/44.26
	G	US-5,170,385	12-1992	Senshu et al.	369/47.21
	Н	US-			
	ı	US-			
	j	US-			
•	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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	s					
	Т					

NON-PATENT DOCUMENTS

MONT / MENT BOOGHIEM								
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
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	w							
	х							

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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